FORM PTO-1449/A and B (modified PTO/SB/08)

## INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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APPLICANT:

Chan et al.

Sheet

**GROUP ART UNIT:** 1637

EXAMINER: Stephanie Kane Mummert

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<sup>#</sup> EXAMINER: Initial if reference considered, whether or noticitation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

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